

# DATA SHEET

## **BUW12F; BUW12AF** Silicon diffused power transistors

Product specification  
Supersedes data of February 1996  
File under Discrete Semiconductors, SC06

1997 Aug 14

Silicon diffused power transistors

BUW12F; BUW12AF

DESCRIPTION

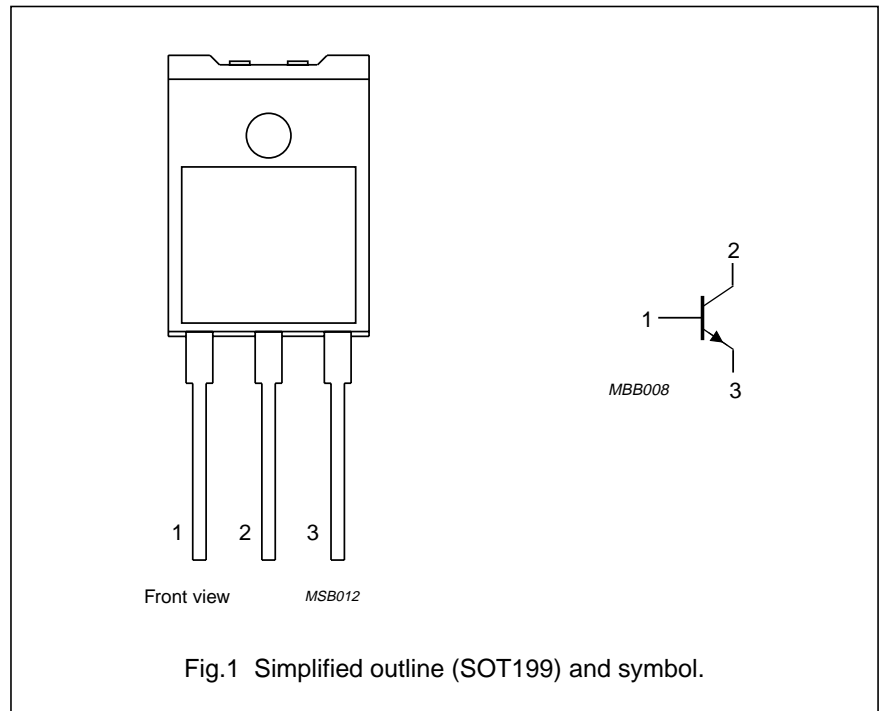
High-voltage, high-speed, glass-passivated NPN power transistor in a SOT199 package.

APPLICATIONS

- Converters
- Inverters
- Switching regulators
- Motor control systems.

PINNING

| PIN | DESCRIPTION                          |
|-----|--------------------------------------|
| 1   | base                                 |
| 2   | collector                            |
| 3   | emitter                              |
| mb  | mounting base; electrically isolated |



QUICK REFERENCE DATA

| SYMBOL      | PARAMETER                            | CONDITIONS                                      | MAX.        | UNIT          |
|-------------|--------------------------------------|---|-------------|---------------|
| $V_{CESM}$  | collector-emitter peak voltage       | $V_{BE} = 0$                                    | 850<br>1000 | V<br>V        |
|             | BUW12F                               |   |             |               |
| $V_{CEO}$   | collector-emitter voltage            | open base                                       | 400<br>450  | V<br>V        |
|             | BUW12F                               |   |             |               |
| $V_{CEsat}$ | collector-emitter saturation voltage | see Figs 6 and 10                               | 1.5         | V             |
|             | BUW12AF                              |   |             |               |
| $I_{Csat}$  | collector saturation current         |   | 6<br>5      | A<br>A        |
|             | BUW12F                               |   |             |               |
| $I_C$       | collector current (DC)               | see Figs 2 and 5                                | 8           | A             |
|             | BUW12AF                              |   |             |               |
| $I_{CM}$    | collector current (peak value)       | see Fig 2                                       | 20          | A             |
| $P_{tot}$   | total power dissipation              | $T_h \leq 25\text{ }^\circ\text{C}$ ; see Fig.4 | 34          | W             |
| $t_f$       | fall time                            | resistive load; see Figs 12 and 13              | 0.8         | $\mu\text{s}$ |

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## THERMAL CHARACTERISTICS

| SYMBOL              | PARAMETER   | CONDITIONS | VALUE | UNIT |
|---------------------|---|------------|-------|------|
| R <sub>th j-h</sub> | thermal resistance from junction to external heatsink | note 1     | 3.7   | K/W  |
|                     |   | note 2     | 2.8   | K/W  |
| R <sub>th j-a</sub> | thermal resistance from junction to ambient           |            | 35    | K/W  |

## Notes

1. Mounted **without** heatsink compound and 30 ±5 N force on centre of package.
2. Mounted **with** heatsink compound and 30 ±5 N force on centre of package.

## LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL            | PARAMETER   | CONDITIONS                                | MIN. | MAX. | UNIT |
|-------------------|---|---|------|------|------|
| V <sub>CESM</sub> | collector-emitter peak voltage<br>BUW12F<br>BUW12AF | V <sub>BE</sub> = 0                       | –    | 850  | V    |
|                   |   |   | –    | 1000 | V    |
| V <sub>CEO</sub>  | collector-emitter voltage<br>BUW12F<br>BUW12AF      | open base                                 | –    | 400  | V    |
|                   |   |   | –    | 450  | V    |
| I <sub>Csat</sub> | collector saturation current<br>BUW12F<br>BUW12AF   | V <sub>CE</sub> = 1.5 V                   | –    | 6    | A    |
|                   |   |   | –    | 5    | A    |
| I <sub>C</sub>    | collector current (DC)                              | see Figs 2 and 5                          | –    | 8    | A    |
| I <sub>CM</sub>   | collector current (peak value)                      | see Fig 2                                 | –    | 20   | A    |
| I <sub>B</sub>    | base current (DC)                                   |   | –    | 4    | A    |
| I <sub>BM</sub>   | base current (peak value)                           |   | –    | 6    | A    |
| P <sub>tot</sub>  | total power dissipation                             | T <sub>h</sub> ≤ 25 °C; see Fig.4; note 1 | –    | 34   | W    |
|                   |   | T <sub>h</sub> ≤ 25 °C; see Fig.4; note 2 | –    | 45   | W    |
| T <sub>stg</sub>  | storage temperature                                 |   | –65  | +150 | °C   |
| T <sub>j</sub>    | junction temperature                                |   | –    | 150  | °C   |

## Notes

1. Mounted **without** heatsink compound and 30 ±5 N force on centre of package.
2. Mounted **with** heatsink compound and 30 ±5 N force on centre of package.

## ISOLATION CHARACTERISTICS

| SYMBOL             | PARAMETER  | MAX. | UNIT |
|--------------------|--|------|------|
| V <sub>isolM</sub> | isolation voltage from all terminals to external heatsink (peak value) | 1500 | V    |
| C <sub>isol</sub>  | isolation capacitance from collector to external heatsink              | 21   | pF   |

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## CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified.

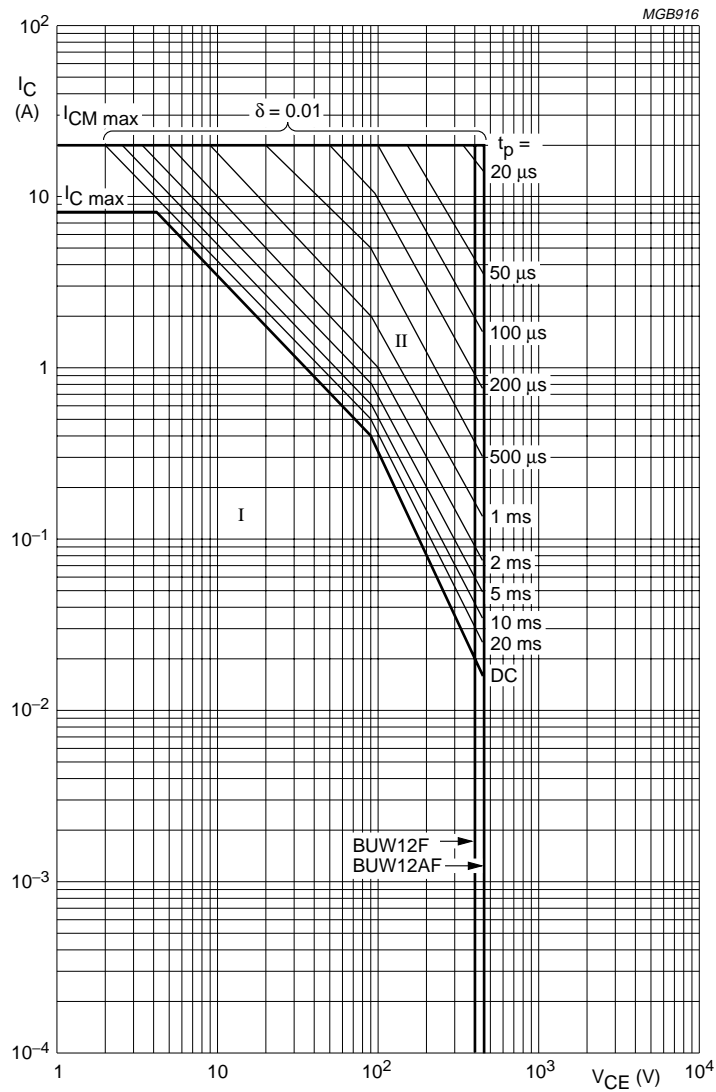
| SYMBOL   | PARAMETER   | CONDITIONS   | MIN. | TYP. | MAX. | UNIT          |
|--|---|--|------|------|------|---------------|
| $V_{CEOsust}$  | collector-emitter sustaining voltage<br>BUW12F<br>BUW12AF | $I_C = 100\text{ mA}$ ; $I_{Boff} = 0$ ; $L = 25\text{ mH}$ ;<br>see Figs 8 and 9                              | 400  | –    | –    | V             |
|  |   |  | 450  | –    | –    | V             |
| $V_{CEsat}$  | collector-emitter saturation voltage<br>BUW12F<br>BUW12AF | $I_C = 6\text{ A}$ ; $I_B = 1.2\text{ A}$ ; see Figs 6 and 10  | –    | –    | 1.5  | V             |
|  |   | $I_C = 5\text{ A}$ ; $I_B = 1\text{ A}$ ; see Figs 6 and 10  | –    | –    | 1.5  | V             |
| $V_{BEsat}$  | base-emitter saturation voltage<br>BUW12F<br>BUW12AF      | $I_C = 6\text{ A}$ ; $I_B = 1.2\text{ A}$ ; see Fig.6  | –    | –    | 1.5  | V             |
|  |   | $I_C = 5\text{ A}$ ; $I_B = 1\text{ A}$ ; see Fig.6  | –    | –    | 1.5  | V             |
| $I_{CES}$  | collector-emitter cut-off current                         | $V_{CE} = V_{CESMmax}$ ; $V_{BE} = 0$ ; note 1   | –    | –    | 1    | mA            |
|  |   | $V_{CE} = V_{CESMmax}$ ; $V_{BE} = 0$ ;<br>$T_j = 125\text{ }^\circ\text{C}$ ; note 1                          | –    | –    | 3    | mA            |
| $I_{EBO}$  | emitter-base cut-off current                              | $V_{EB} = 9\text{ V}$ ; $I_C = 0$  | –    | –    | 10   | mA            |
| $h_{FE}$   | DC current gain   | $V_{CE} = 5\text{ V}$ ; $I_C = 10\text{ mA}$ ; see Fig.11  | 10   | 18   | 35   |               |
|  |   | $V_{CE} = 5\text{ V}$ ; $I_C = 1\text{ A}$ ; see Fig.11  | 10   | 20   | 35   |               |
| <b>Switching times resistive load</b> (see Figs 12 and 13) |   |  |      |      |      |               |
| $t_{on}$   | turn-on time<br>BUW12F<br>BUW12AF                         | $I_{Con} = 6\text{ A}$ ; $I_{Bon} = I_{Boff} = 1.2\text{ A}$   | –    | –    | 1    | $\mu\text{s}$ |
|  |   | $I_{Con} = 5\text{ A}$ ; $I_{Bon} = I_{Boff} = 1\text{ A}$   | –    | –    | 1    | $\mu\text{s}$ |
| $t_s$  | storage time<br>BUW12F<br>BUW12AF                         | $I_{Con} = 6\text{ A}$ ; $I_{Bon} = I_{Boff} = 1.2\text{ A}$   | –    | –    | 4    | $\mu\text{s}$ |
|  |   | $I_{Con} = 5\text{ A}$ ; $I_{Bon} = I_{Boff} = 1\text{ A}$   | –    | –    | 4    | $\mu\text{s}$ |
| $t_f$  | fall time<br>BUW12F<br>BUW12AF                            | $I_{Con} = 6\text{ A}$ ; $I_{Bon} = I_{Boff} = 1.2\text{ A}$   | –    | –    | 0.8  | $\mu\text{s}$ |
|  |   | $I_{Con} = 5\text{ A}$ ; $I_{Bon} = I_{Boff} = 1\text{ A}$   | –    | –    | 0.8  | $\mu\text{s}$ |
| <b>Switching times inductive load</b> (see Figs 14 and 15) |   |  |      |      |      |               |
| $t_s$  | storage time<br>BUW12F<br>BUW12AF                         | $I_{Con} = 6\text{ A}$ ; $I_B = 1.2\text{ A}$ ; $V_{CL} = 250\text{ V}$ ;<br>$T_c = 100\text{ }^\circ\text{C}$ | –    | 1.9  | 2.5  | $\mu\text{s}$ |
|  |   | $I_{Con} = 5\text{ A}$ ; $I_B = 1\text{ A}$ ; $V_{CL} = 300\text{ V}$ ;<br>$T_c = 100\text{ }^\circ\text{C}$   | –    | 1.9  | 2.5  | $\mu\text{s}$ |
| $t_f$  | fall time<br>BUW12F<br>BUW12AF                            | $I_{Con} = 6\text{ A}$ ; $I_B = 1.2\text{ A}$ ; $V_{CL} = 250\text{ V}$ ;<br>$T_c = 100\text{ }^\circ\text{C}$ | –    | 200  | 300  | ns            |
|  |   | $I_{Con} = 5\text{ A}$ ; $I_B = 1\text{ A}$ ; $V_{CL} = 300\text{ V}$ ;<br>$T_c = 100\text{ }^\circ\text{C}$   | –    | 200  | 300  | ns            |

## Note

1. Measured with a half-sinewave voltage (curve tracer).

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Mounted **without** heatsink compound and  $30 \pm 5$  N force on centre of package.

$T_{mb} < 25$  °C.

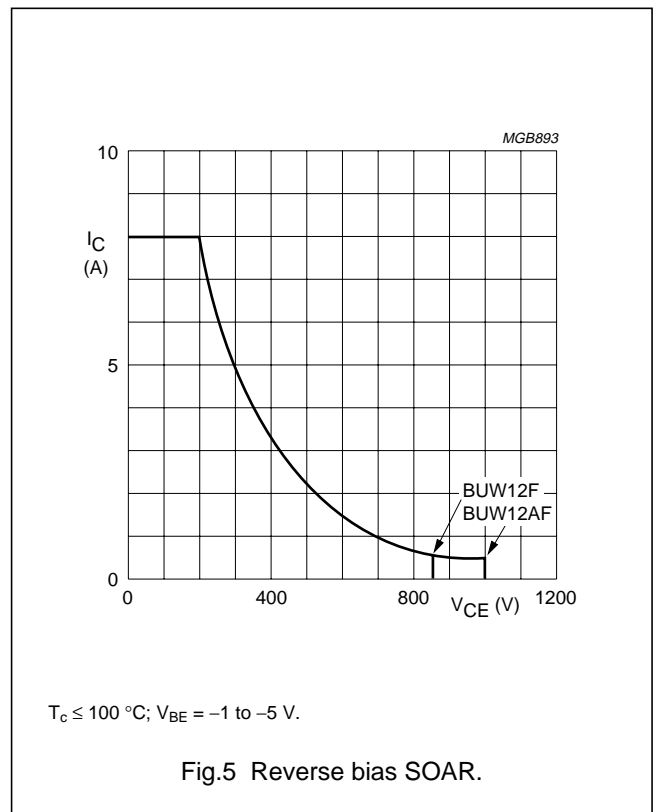
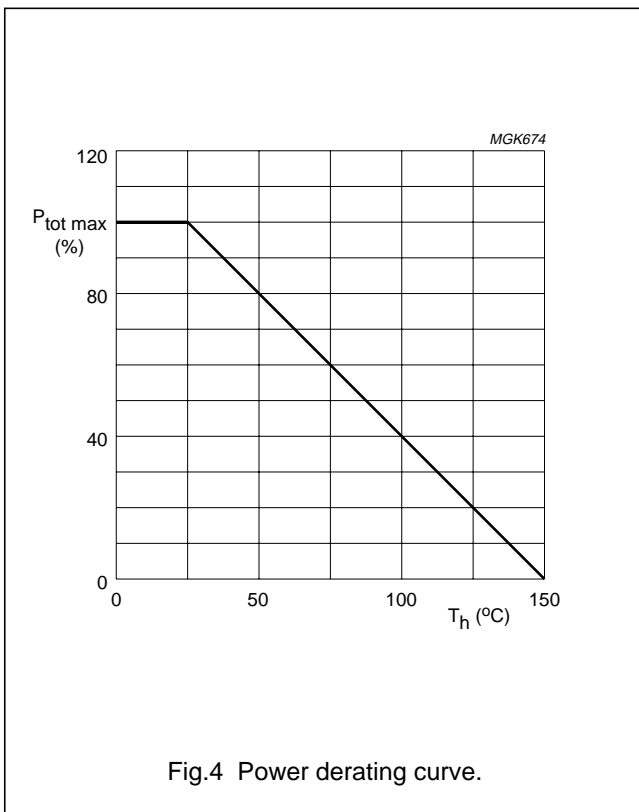
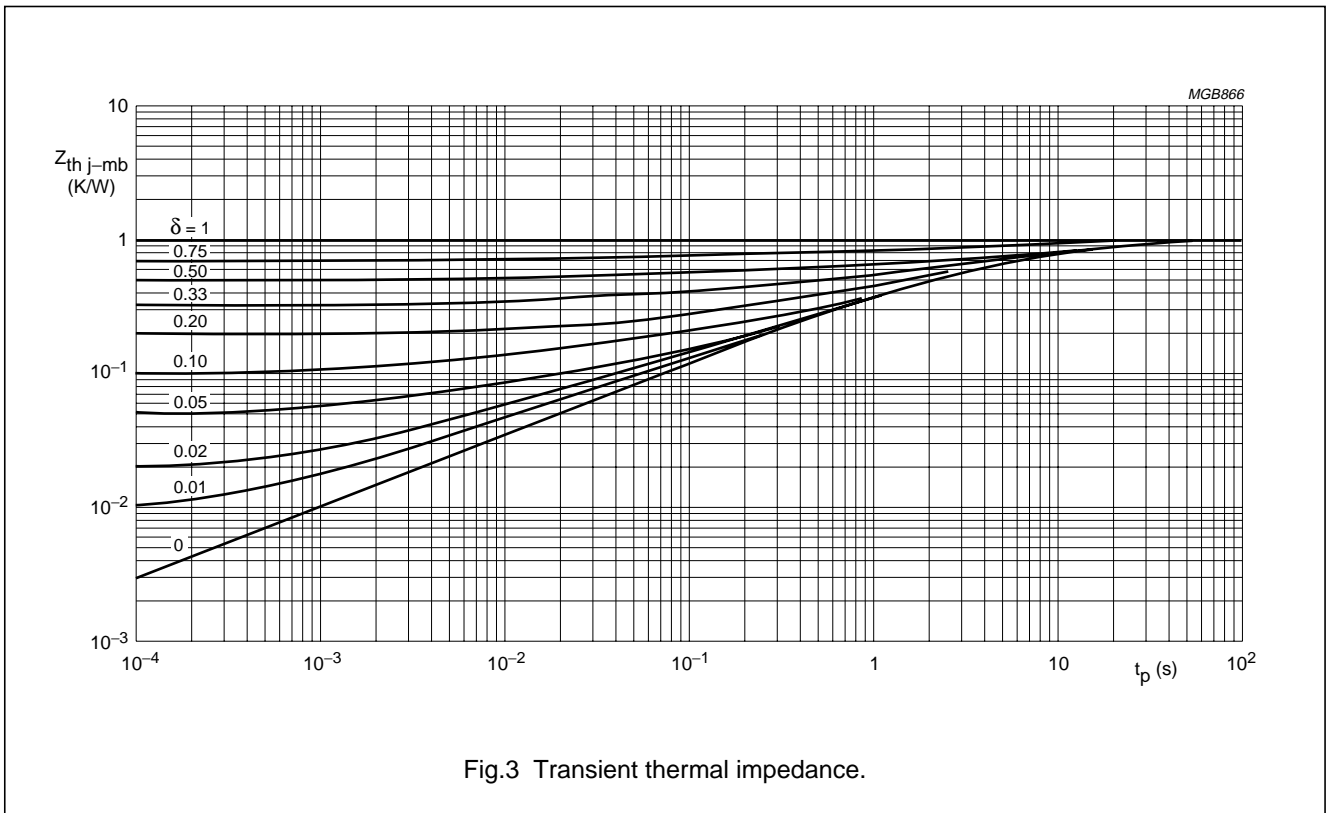
I - Region of permissible DC operation.

II - Permissible extension for repetitive pulse operation.

Fig.2 Forward bias SOAR.

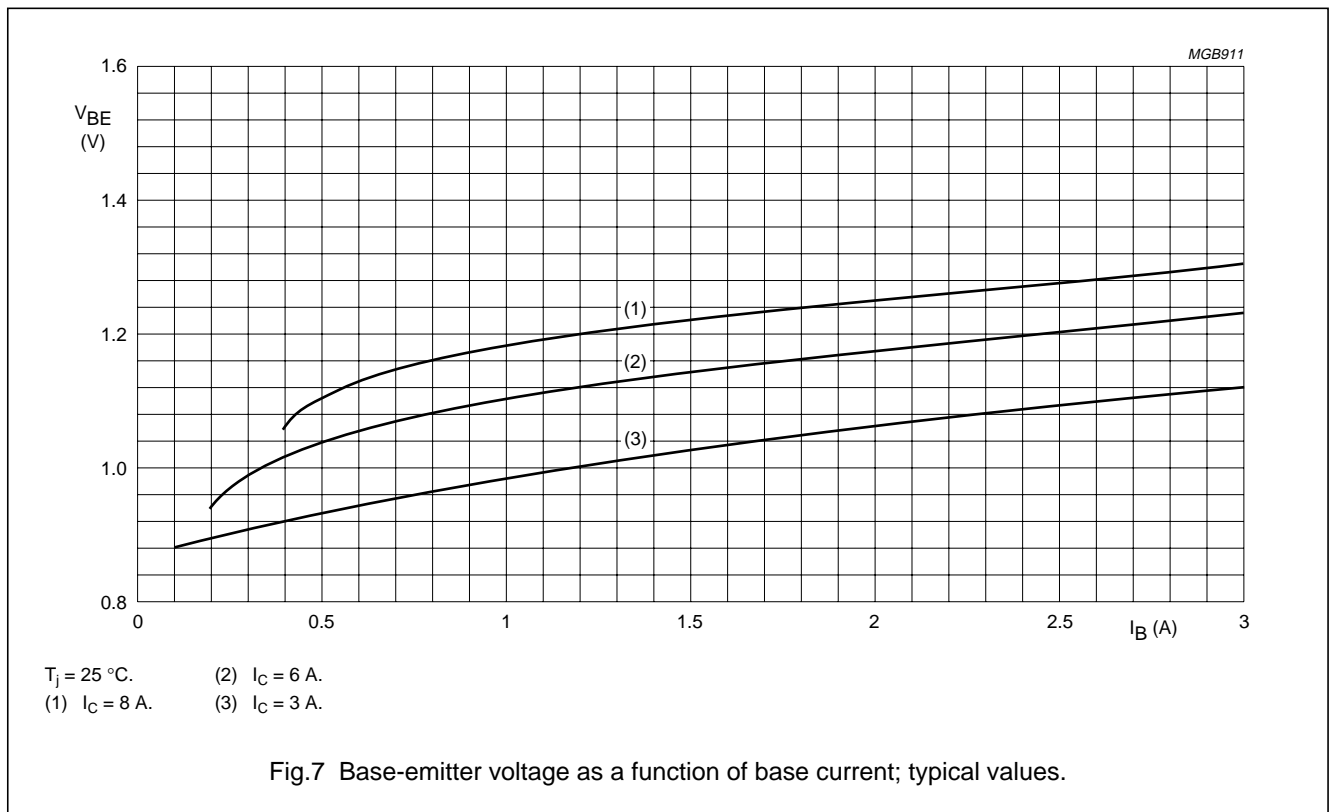
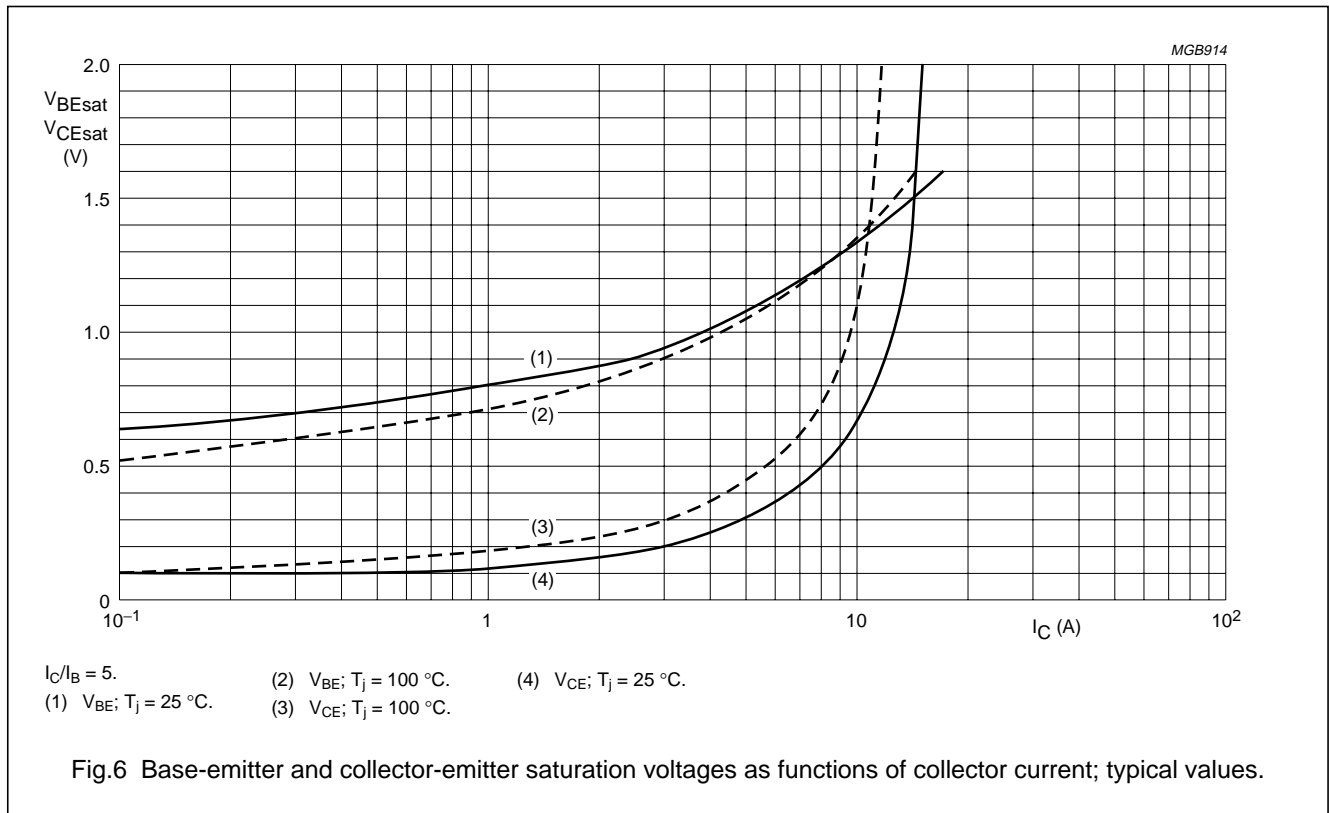
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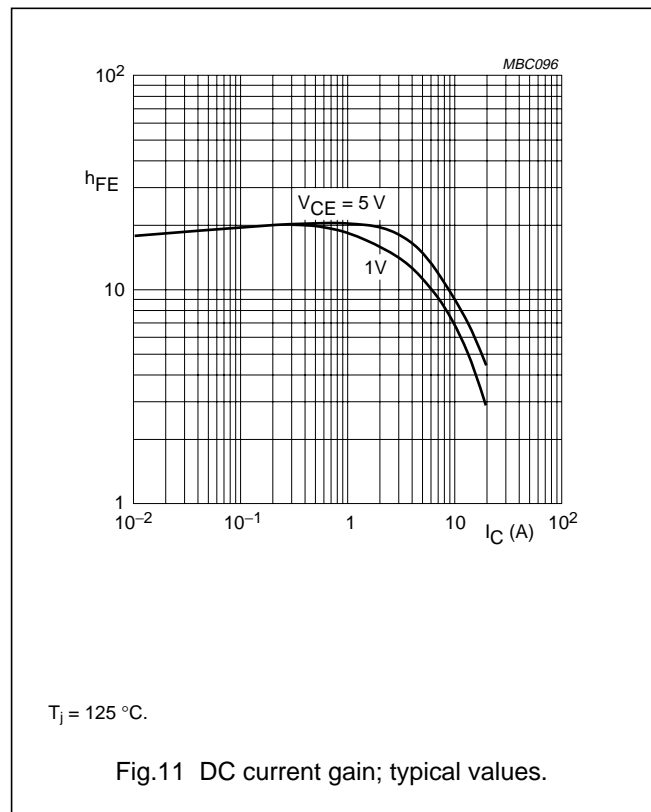
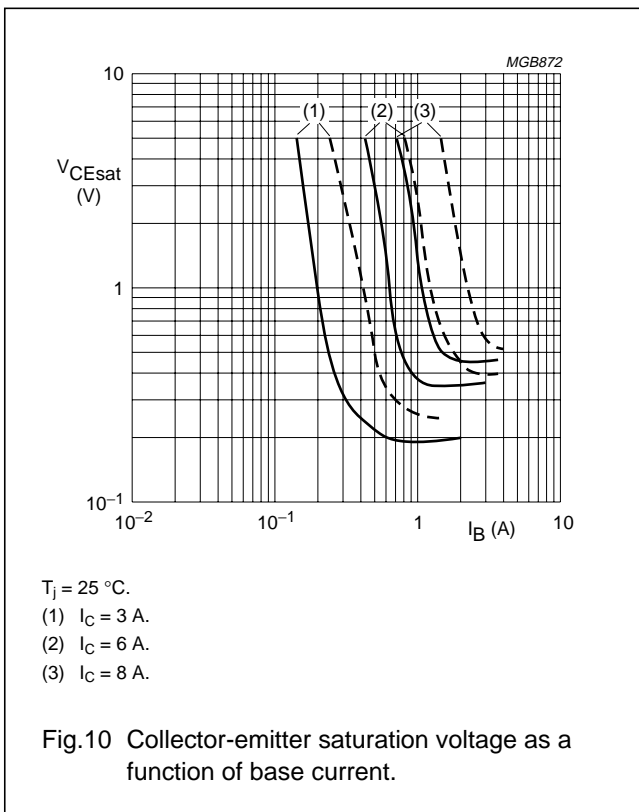
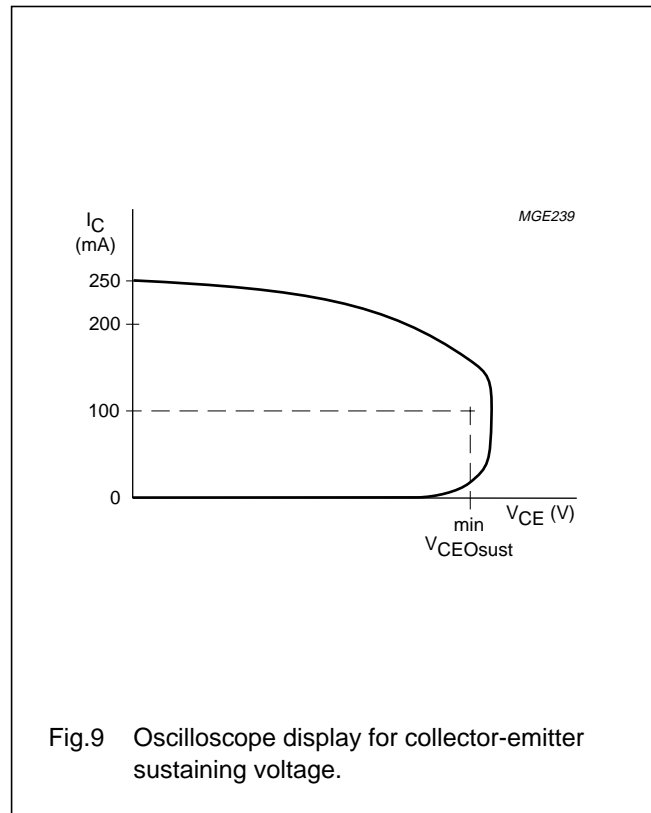
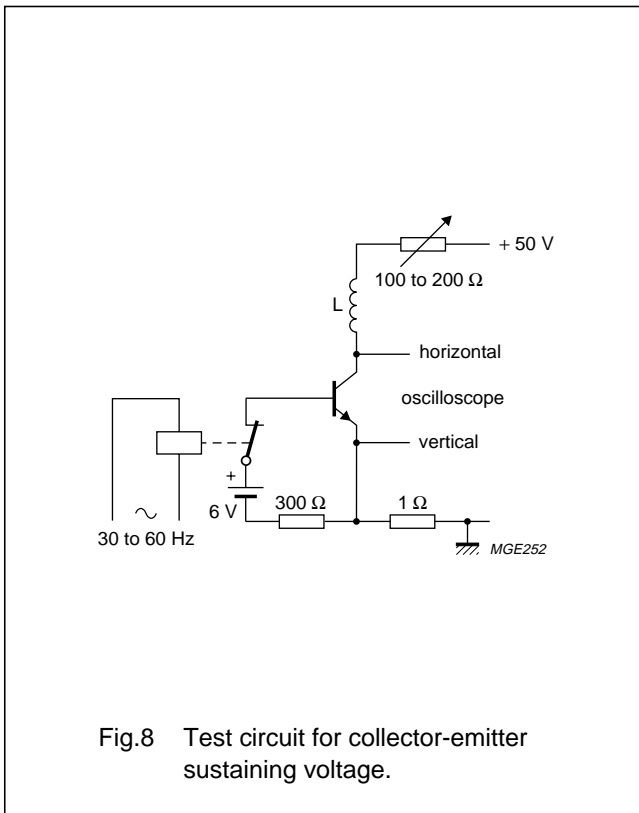
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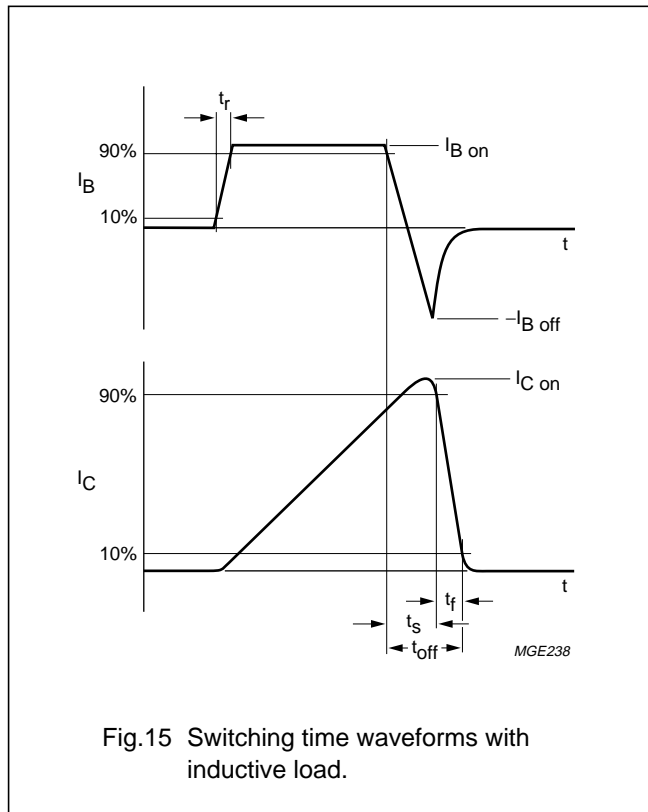
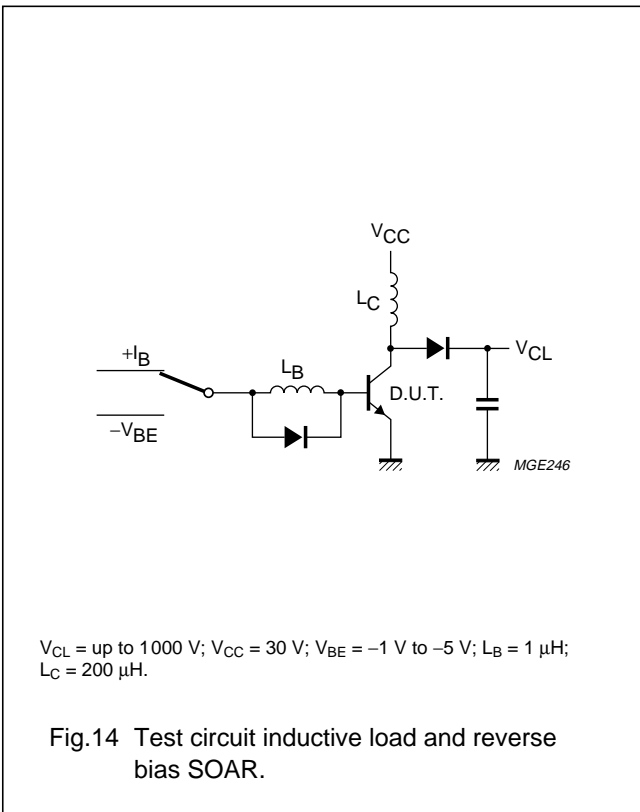
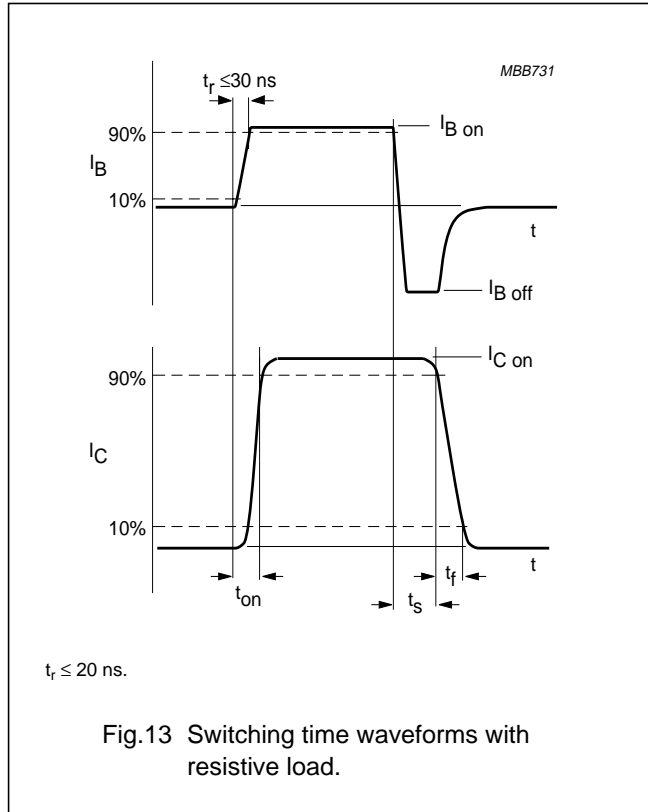
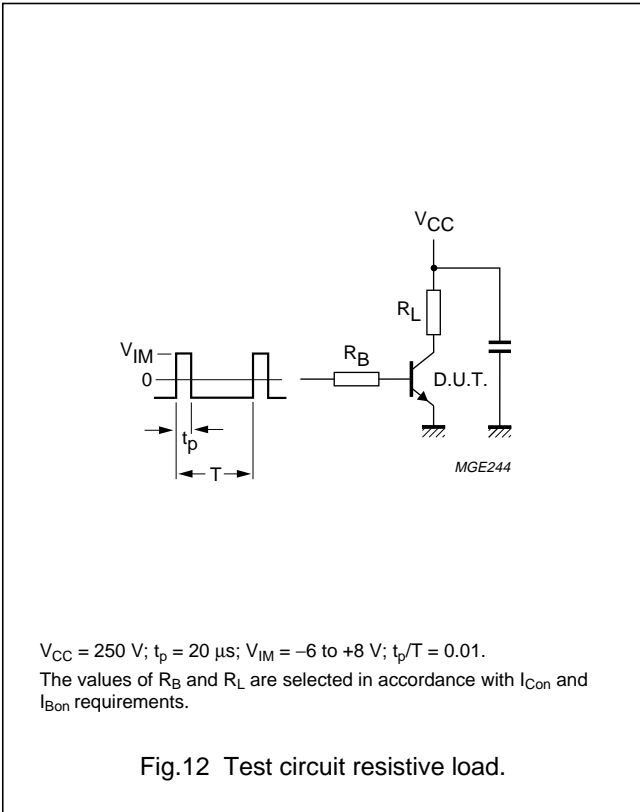
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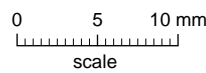
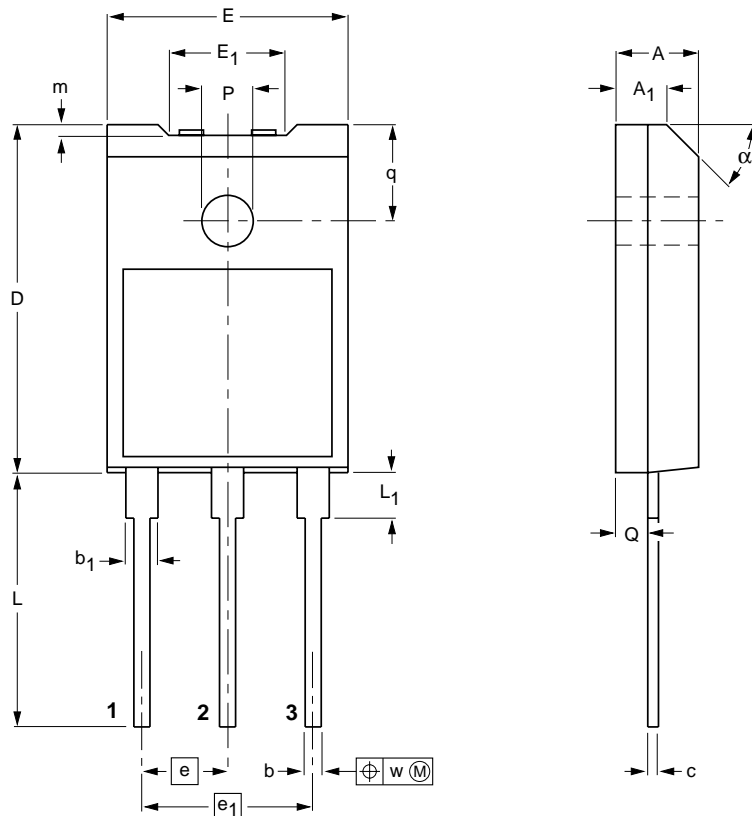
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PACKAGE OUTLINE

Plastic single-ended package; heatsink mounted; 1 mounting hole; 3 leads (in-line)

SOT199



DIMENSIONS (mm are the original dimensions)

| UNIT | A          | A <sub>1</sub> | b          | b <sub>1</sub> | c          | D            | E            | E <sub>1</sub> | e    | e <sub>1</sub> | L            | L <sub>1</sub> <sup>(1)</sup> | m          | P          | Q          | q          | w   | α   |
|------|------------|----------------|------------|----------------|------------|--------------|--------------|----------------|------|----------------|--------------|-------------------------------|------------|------------|------------|------------|-----|-----|
| mm   | 5.2<br>4.8 | 3.4<br>3.0     | 1.2<br>1.0 | 2.1<br>1.9     | 0.6<br>0.5 | 21.5<br>20.5 | 15.3<br>14.7 | 7.8<br>6.8     | 5.45 | 10.9           | 16.5<br>15.7 | 3.7<br>3.3                    | 0.8<br>0.6 | 3.3<br>3.1 | 2.1<br>1.9 | 6.2<br>5.8 | 0.4 | 45° |

Note

1. Terminals in this zone are not tinned.

| OUTLINE VERSION | REFERENCES |       |      |  | EUROPEAN PROJECTION | ISSUE DATE |
|-----------------|------------|-------|------|--|---------------------|------------|
|                 | IEC        | JEDEC | EIAJ |  |                     |            |
| SOT199          |            |       |      |  |                     | 97-06-27   |

## Silicon diffused power transistors

## BUW12F; BUW12AF

**DEFINITIONS**

|   |   |
|---|---|
| <b>Data sheet status</b>  |   |
| Objective specification   | This data sheet contains target or goal specifications for product development.       |
| Preliminary specification   | This data sheet contains preliminary data; supplementary data may be published later. |
| Product specification   | This data sheet contains final product specifications.                                |
| <b>Limiting values</b>  |   |
| Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability. |   |
| <b>Application information</b>  |   |
| Where application information is given, it is advisory and does not form part of the specification.   |   |

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